. . . . Application/Control No. :Applicant(s)/Patent Under Reexamination 10/566,977 NAKAMURA ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 Mark H. Paschall 3742 U.S. PATENT DOCUMENTS **Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,797,414 08-1998 Sirovich et al. Α 137/13 US-В US-С US-D US-Ε US-F G US-Н US-US-١ US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0

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